

## STL20NM20N

# N-CHANNEL 200V - 0.088Ω - 20A PowerFLAT™ ULTRA LOW GATE CHARGE MDmesh™ II MOSFET

**Table 1: General Features** 

TYPE	V <sub>DSS</sub> R <sub>DS(on)</sub>		I <sub>D</sub>
STL20NM20N	200 V	< 0.105 Ω	20 A

- WORLDWIDE LOWEST GATE CHARGE
- TYPICAL  $R_{DS}(on) = 0.088\Omega$
- IMPROVED DIE-TO-FOOTPRINT RATIO
- VERY LOW PROFILE PACKAGE (1mm MAX)
- VERY LOW THERMAL RESISTANCE
- LOW GATE RESISTANCE
- LOW INPUT CAPACITANCE
- HIGH dv/dt and AVALANCHE CAPABILITIES

#### DESCRIPTION

This 200V MOSFET with a new advanced layout brings all unique advantages of MDmesh technology to lower voltages. The device exhibits worldwide lowest gate charge for any given onresistance. Its use is therefore ideal as primary switch in isolated DC-DC converters for Telecon and Computer applications. Used in combination with secondary-side low-voltage STripFFT improducts, it contributes to reducing losses and boosting efficiency. The new PowerFLATTM package allows a significant reduction in board space without compromising performance.

#### APPLICATIONS

The MDmesh™ family is ve y suitable for increasing power density allowing system miniaturization and higher efficiencies

Figure 1: Package

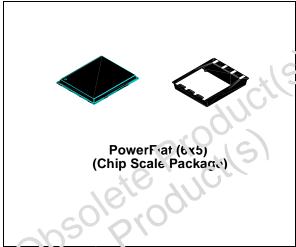


Figure 2: Internal Schematic Diagram

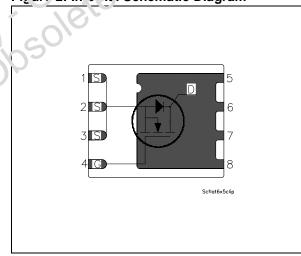


Table 2: Order Codes

SALES TYPE	MARKING	PACKAGE	PACKAGING
STL20NM20N	L20NM20N	PowerFLAT™(6x5)	TAPE & REEL

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**Table 3: Absolute Maximum ratings** 

Symbol	Parameter	Value	Unit
$V_{DS}$	Drain-source Voltage (V <sub>GS</sub> = 0)	200	V
$V_{DGR}$	Drain-gate Voltage (R <sub>GS</sub> = 20 k $\Omega$ )	200	V
$V_{GS}$	Gate- source Voltage	± 30	V
I <sub>D</sub> (1)	Drain Current (continuous) at T <sub>C</sub> = 25°C (Steady State) Drain Current (continuous) at T <sub>C</sub> = 100°C	20 12.3	A A
I <sub>DM</sub> (3)	Drain Current (pulsed)	80	А
P <sub>TOT</sub> (2)	Total Dissipation at T <sub>C</sub> = 25°C (Steady State)	2.5	W
P <sub>TOT</sub> (1)	Total Dissipation at T <sub>C</sub> = 25°C (Steady State)	80	W
	Derating Factor (2)	0.02	W/°C
dv/dt (4)	Peak Diode Recovery voltage slope	10	۶٬۱/۱٬

#### **Table 4: Thermal Data**

Symbol	Parameter	Тур.	Max.	Unit
Rthj-c	Thermal Resistance Junction-case		1.56	°C/W
Rthj-pcb (2)	Thermal Resistance Junction-pcb	35	50	°C/W
T <sub>j</sub> T <sub>stg</sub>	Max. Operating Junction Temperature Storage Temperature	-55 to	150	°C

#### **Table 5: Avalanche Characteristics**

Symbol	Parameter		Max. Value	Unit
I <sub>AS</sub>	Avalanche Current, Repetitive or Not-Repetitive (pulse width limited by T <sub>j</sub> max)	~O)	20	А
E <sub>AS</sub>	Single Pulse Avalanche Energy (starting $T_j = 25$ °C, $I_D = I_{AR}$ , $V_{LNL} = 35$ V)	)3	380	mJ

## ELECTRICAL CHARACTINISTICS (T<sub>CASE</sub> =25°C UNLESS OTHERWISE SPECIFIED)

#### Table 6: On/Off

Symbol	i'a. ar ieter	Test Conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Dr⊾irsource Breakdown Voltage	$I_D = 1 \text{ mA}, V_{GS} = 0$	200			V
Ins';	Zero Gate Voltage Drain Current (V <sub>GS</sub> = 0)	$V_{DS}$ = Max Rating $V_{DS}$ = Max Rating, $T_{C}$ = 125 °C			1 10	μA μA
IGSS	Gate-body Leakage Current (V <sub>DS</sub> = 0)	V <sub>GS</sub> = ± 30 V			±100	nA
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	3	4	5	V
R <sub>Ds(on)</sub>	Static Drain-source On Resistance	V <sub>GS</sub> = 10V, I <sub>D</sub> = 10 A		0.088	0.105	Ω

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#### **ELECTRICAL CHARACTERISTICS (CONTINUED)**

**Table 7: Dynamic** 

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
g <sub>fs</sub> (5)	Forward Transconductance	V <sub>DS</sub> = 15 V <sub>,</sub> I <sub>D</sub> = 10 A		8		S
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub>	Input Capacitance Output Capacitance Reverse Transfer Capacitance	$V_{DS} = 25 \text{ V, } f = 1 \text{ MHz, } V_{GS} = 0$		800 330 130		pF pF pF
C <sub>oss eq.</sub> (*)	Equivalent Output Capacitance	$V_{GS} = 0V, V_{DS} = 0V \text{ to } 160 \text{ V}$		225		pF
t <sub>d(on)</sub> t <sub>r</sub> t <sub>d(off)</sub> t <sub>f</sub>	Turn-on Delay Time Rise Time Turn-off Delay Time Fall Time	$V_{DD} = 100 \text{ V}, I_D = 10 \text{ A}$ $R_G = 4.7\Omega \text{ V}_{GS} = 10 \text{ V}$ (see Figure 16)		40 15 40 11	4.1	ns ns ns
Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub>	Total Gate Charge Gate-Source Charge Gate-Drain Charge	$V_{DD} = 160 \text{ V}, I_{D} = 20 \text{ A},$ $V_{GS} = 10 \text{ V}$ (see Figure 19)		32 6 25	70	nC nC nC

<sup>(\*)</sup> Coss eq. is defined as a constant equivalent capacitance giving the same charging time as Coss when VDS i creases from 0 to 80% VDSS

**Table 8: Source Drain Diode** 

Symbol	Parameter	Test Conditions	M₁n.	Тур.	Max.	Unit
I <sub>SD</sub>	Source-drain Current	1050	70	9	20	Α
I <sub>SDM</sub> (3)	Source-drain Current (pulsed)				80	Α
V <sub>SD</sub> (5)	Forward On Voltage	I <sub>SD</sub> = 20 A, V <sub>GS</sub> = c	,		1.3	V
t <sub>rr</sub> Q <sub>rr</sub> I <sub>RRM</sub>	Reverse Recovery Time Reverse Recovery Charge Reverse Recovery Current	$I_{SD} = 20 \text{ A, di/dt} = 100 \text{ A/µs,}$ $V_{DD} = 100 \text{ V. } T_j = 25^{\circ}\text{C}$ (Set Figure 17)		160 960 128		ns nC A
t <sub>rr</sub> Q <sub>rr</sub> I <sub>RRM</sub>	Reverse Recovery Time Reverse Recovery Charge Reverse Recovery Current	$ S_D  = 20 \text{ A, di/dt} = 100 \text{ A/µs,}$ $ V_{DD}  = 100 \text{ V, T}_j = 150^{\circ}\text{C}$ (see Figure 17)		225 1642 15		ns nC A

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- Note: 1. The value is rated according to R<sub>thj-c</sub>.

  2. When Mounted on F\(\times\) 4 Board of 1inch<sup>2</sup>, 2 oz Cu

  3. Pulse width limite 1 L / s ife operating area

  - 4.  $I_{SD} \le 20A$ , 1i/c  $t < 400A/\mu s$ ,  $V_{DD} \le V_{(BR)DSS}$
  - 5. Pulsed: Puls : duration = 300 μs, duty cycle 1.5 %

Figure 3: Safe Operating Area

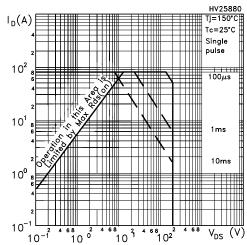


Figure 4: Output Characteristics

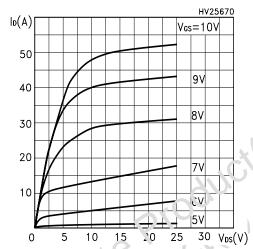


Figure 5: Transcon luctance

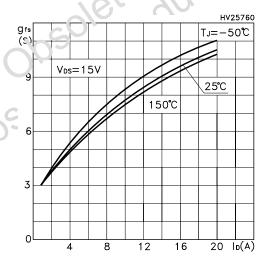


Figure 6: Thermal Impedance

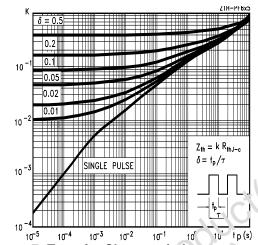


Figure 7: Transfer Characteristics

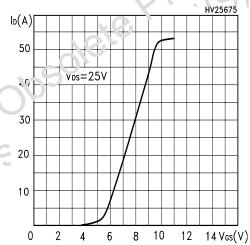
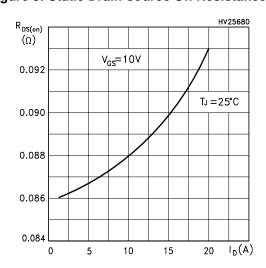


Figure 8: Static Drain-source On Resistance



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Figure 9: Gate Charge vs Gate-source Voltage

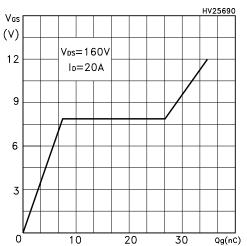


Figure 10: Normalized Gate Thereshold Voltage vs Temperature

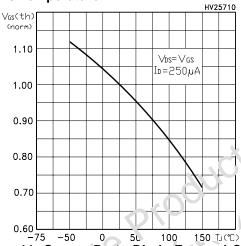


Figure 11: Source-Drain Diode Forward Characteristics

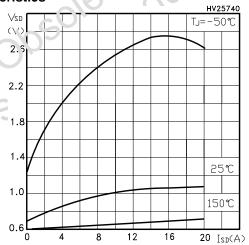


Figure 12: Capacitance Variations

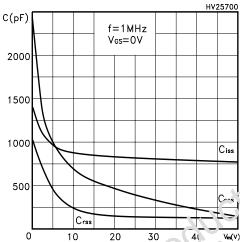


Figure 13: Normalized On Resistance vs Temperature

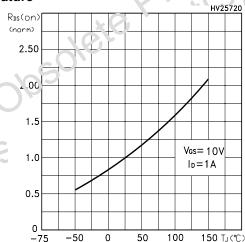


Figure 14: Normalized BVdss vs Temperature

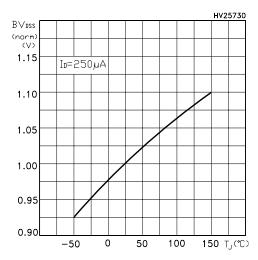


Figure 15: Unclamped Inductive Load Test Circuit

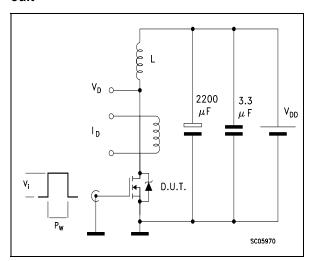


Figure 16: Switching Times Test Circuit For Resistive Load

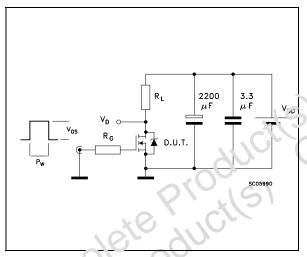


Figure 17. Test Circuit For Inductive Load Switching and Diode Recovery Times

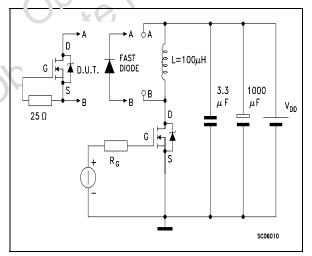


Figure 18: Unclamped Inductive Wafeform

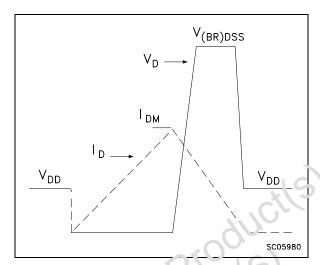
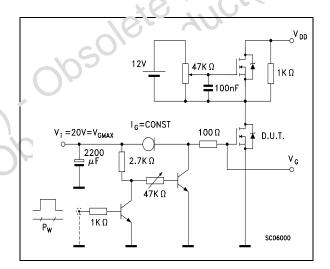


Figure 19: Gate Charge Yest Circuit



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Josolete Product(s)

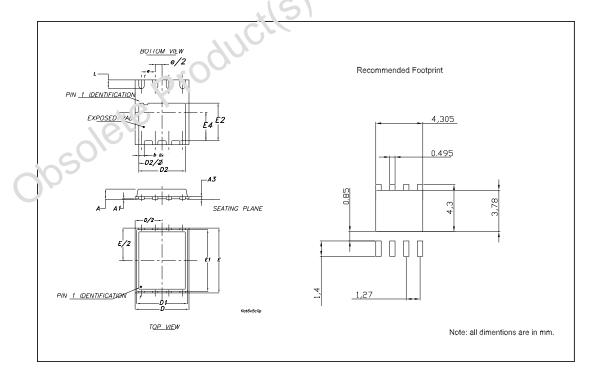
In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: <a href="https://www.st.com">www.st.com</a>



Obsolete Product(s).

### PowerFLAT™ (6x5) MECHANICAL DATA

DIM		mm.			inch	
DIM.	MIN.	TYP	TYP MAX.		MIN. TYP.	
А	0.80	0.83	0.93	0.031	0.032	0.036
A1		0.02	0.05		0.0007	0.0019
A3		0.20			0.007	
b	0.35	0.40	0.47	0.013	0.015	0.018
D		5.00			0.196	1111
D1		4.75			0.187	000
D2	4.15	4.20	4.25	0.163	0.165	S.167
E		6.00			0.236	
E1		5.75			0.225	
E2	3.43	3.48	3.53	0.135	0.137	0.139
E4	2.58	2.63	2.68	100	0.103	0.105
е		1.27		UD.	0.050	
L	0.70	0.80	0.90	0.027	0.031	0.035



**Table 9: Revision History** 

Date	Revision	Description of Changes	
16-Feb-2005	2	New stylesheet	
		Some Values changed on table 6 and 8	
09-Jun-2005	3	Inserted curves	
20-Jun-2005	4	Updated mechanical data	
04-Nov-2005	5	Modified value on table 8, inserted ecopack indication	
09-Jan-2006	6	New footprint	

Obsolete Product(s) obsolete Product(s)
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